Search Notes

Application/Control N	No. Applicant(s)/Patent under Reexamination	٢
10/551,048	APFELBACHER ET AL.	
Examiner	Art Unit	
Hae M. Hyeon	2830	

	SEARCHED				
Class	Subclass	Date	Examiner		
439	76.1	6/01	hanh		
257	415		,		
361	93.1				
439	701				
361	141				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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